AMENDMENTS TO THE CLAIMS

Please amend the claims as follows:

1. (Original)

at least one absorber layer, and
at least one doped window layer having at least two sub-layers, wherein the
first sub-window-layer is adjacent the absorber layer and forms a desirable junction with the

absorber-layer and wherein the second sub-window-layer is adjacent the first sub-window-

A novel photovoltaic solar cell comprising:

layer and has high optical transmission.

- 2. (Currently Amended) The solar cell of claim 1, wherein the photovoltaic cell comprises an a thin film silicon (tf-Si) alloy based solar cell including at least one of amorphous silicon (a-Si:H) based solar cell, nanocrystalline silicon (nc-Si:H) based solar cell, microcrystalline silicon (µc-Si:H) based solar, polycrystalline silicon (poly-Si:H) based solar cell, or other combinations and mixtures.
- 3. (Original) The solar cell of claim 2, wherein the photovoltaic cell including at least one of a-Si:H, a-Si_(1-x)Ge_x:H and other combinations and mixtures.
- 4. (Original) The solar cell of claim 2 wherein the doped window-layer comprises a p-type layer or an n-type layer.
- 5. (Original) The solar cell of claim 2, wherein the doped window-layer is formed using vapor phase deposition.
- 6. (Original) The solar cell of claim 5, wherein the doped window-layer is formed using plasma enhanced chemical vapor deposition.

- 7. (Original) The solar cell of claim 5, wherein the desirable deposition conditions are achieved by varying parameters including at least one of the following: temperature, composition of gas mixtures, rf power, pressure, reactor geometry and dilution with gases such as hydrogen.
- 8. (Original) The solar cell of claim 7, where the sub-window-layer is a p-type layer.
- 9. (Original) The solar cell of claim 7, wherein the deposition parameter adjusted to achieve desirable semiconductor properties is temperature.
- 10. (Original) The solar cell of claim 1, having a conversion efficiency of about 10% or greater.
- 11. (Original) The solar cell of claim 1, further comprising a substrate selected from at least one of: glass, metal or plastic.
- 12. (Original) The solar cell of claim 11, further comprising a suitable transparent conductive oxide layer adjacent the second sub-window-layer.
- 13. (Original) The solar cell of claim 1, further comprising an encapsulation layer overlaying the solar cell to provide a substantially airtight and watertight protective barrier against moisture and contaminants.
- 14. (Original) The solar cell of claim 1, further comprising a buffer semiconductor layer between the absorber-layer and the first sub-window-layer.
- 15. (Original) The solar cell of claim 4, wherein the first and second subwindow layers each comprise silicon-containing materials.

- 16. (Original) The solar cell of claim 15, wherein the absorber-layer comprises hydrogenated amorphous silicon germanium.
 - 17. (Original) A method for manufacturing a solar cell comprising the steps of
 - (i) providing a substrate;
- (ii) depositing semiconductor layers that comprise at least one absorber layer and at least one doped-window-layer, wherein the doped window layer comprises at least two-sub-window-layers deposited under desirable deposition conditions; and,
- (iii) depositing a layer of transparent conducting oxide next to the doped-windowlayer but not in direct contact with the absorber layer.
- 18. (Original) The method of claim 17, in which the first sub-window-layer is adjacent to the absorber layer and is deposited under conditions which achieve a desirable junction with the absorber layer; and in which the second sub-window-layer is adjacent the first sub-window-layer but not directly in contact with the absorber-layer and is deposited under conditions which achieve high optical transmission.
- 19. (Original) The method of claim 18, further including depositing the doped window layer before deposition of the semiconductor absorber layer.
- 20. (Original) The method of claim 18, further including depositing the doped window layer after deposition of the semiconductor absorber layer.
- 21. (Original) The method of claim 18, wherein the absorber layer contains silicon and germanium and during the absorber layer deposition an optimized ratio of germane-containing gas and silicon-containing gas provides a Ge content suitable for forming a high efficiency single-junction solar cell.

- 22. (Original) The method of claim 18, wherein the first and second subwindow-layers are deposited by a vapor phase deposition process.
- 23. (Original) The method of claim 22, wherein the vapor phase deposition process comprises plasma enhanced chemical vapor deposition.
- 24. (Original) The method of claim 23, in which the plasma enhanced chemical vapor deposition comprises radio frequency plasma enhanced chemical vapor deposition.
- 25. (Original) The method of claim 24, wherein the first and second window-layers silicon-containing material are selected from the group consisting of a-Si:H, a-Si_{1-x}C_x:H, a-Si_{1-x}Ge_x:H, nc-Si_{1-x}Ge_x:H, nc-Si_{1-x}Ge_x:H, μc-Si_{1-x}C_x:H, μc-Si_{1-x}C
- 26. (Original) The method of claim 25, wherein the plasma enhanced chemical vapor deposition is by at least one of the following: cathodic direct current glow discharge, anodic direct current glow discharge, radio frequency glow discharge, very high frequency (VHF) glow discharge, alternate current glow discharge, or microwave glow discharge.
- 27. (Original) The solar cell of claim 8, wherein the first sub-p-layer is deposited at about 140°C.
- 28. (Original) The solar cell of claim 8, wherein the second sub-p-layer has a transparency greater than the transparency of the first sub-p-layer.
- 29. (Original) The solar cell of claim 28, wherein the second sub-p-layer is deposited at a temperature sufficient low to provide acceptable transparency.

30. (Original) The solar cell of claim 29, wherein the second sub-p-layer is deposited at or below a temperature of about 70°C.

31. - 69. Cancelled

- 70. (Original) The solar cell of claim 3, wherein the photovoltaic cell uses intrinsic semiconductor materials a- $Si_{(1-x)}Ge_x$:H with minimal light-induced degradation and appropriate bandgap to achieve high conversion efficiency for single-junction solar cells.
- 71. (Original) The solar cell of claim 70, wherein x is around 0.1 to 0.3 for high-efficiency single-junction solar cell.
- 72. (Original) The solar cell of claim 4, wherein the doped window layer is deposited under conditions that continuously changed from that of first sub-window-layer to that of the second sub-window-layer.
- 73. (Original) The solar cell of claim 4, wherein heavily doped interface layer, with doping level greater than the bulk of the n-layer, is used between the n-layer the a TCO layer.
- 74. (Original) The solar cell of claim 4, wherein a heavily doped p-type interface layer, with a doping level greater than the bulk of p-type doped layer, is used between the p-layer and the TCO layer.